

# Development of cost-effective chemical solution deposition YBCO superconductor tapes

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Federal Ministry  
of Economics  
and Technology

## Outline

### Introduction

- Deutsche Nanoschicht, GmbH
- Process technology: Chemical Solution Deposition (CSD)

### Performance/ YBCO properties

- CSD conductor architecture/ YBCO process
- Performance: 50-100 m long tapes
- Properties: incl. H-, T-,  $\theta$ -dependences

### Summary



## Deutsche Nanoschicht GmbH

Part of BASF group since June 2013

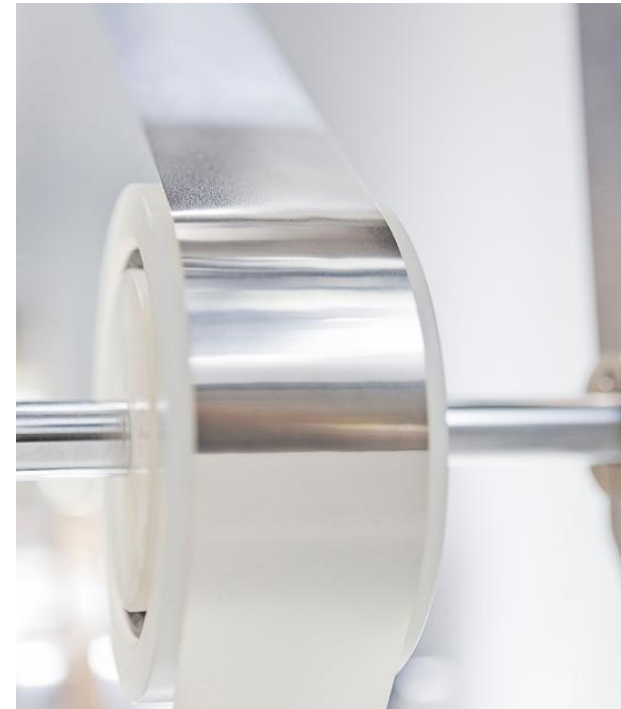
- 63 employees, Rheinbach and Heidelberg, Germany

High Temperature Superconductor (HTS) wires

- ceramic functional layers, magneto-calorics, 3D-printing

Chemical Solution Deposition (CSD)

- unique and protected CSD-multi-layer technology



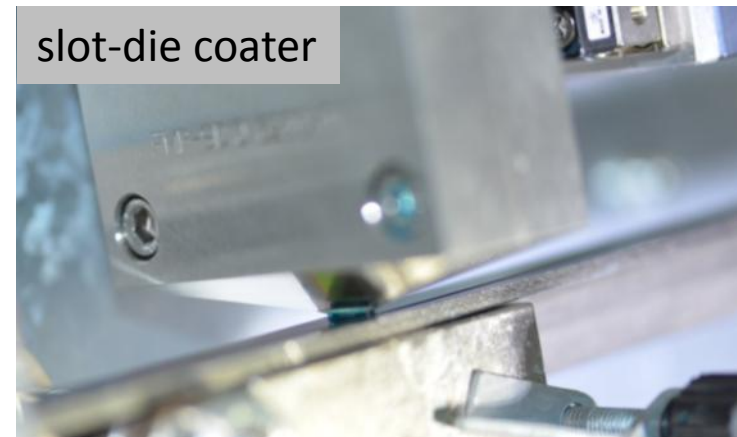


## D-Nano process technology

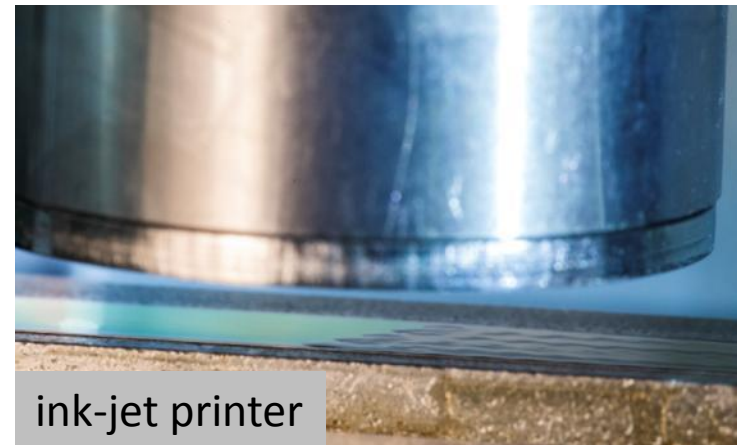
### Chemical Solution Deposition

- All-CSD architecture: Buffer layers, HTS, Ag
  - reduced equipment cost
    - slot-die/ ink-jet deposition (1 atm operation)
    - furnaces (simplified design/ construction)
  - 95+% material usage
  - variable deposition width
    - production volume scales with tape width
- Competitive price/performance ratio (€/kA.m)
- Viable path to large volume ( $10^3$ - $10^4$  km/yr)

slot-die coater

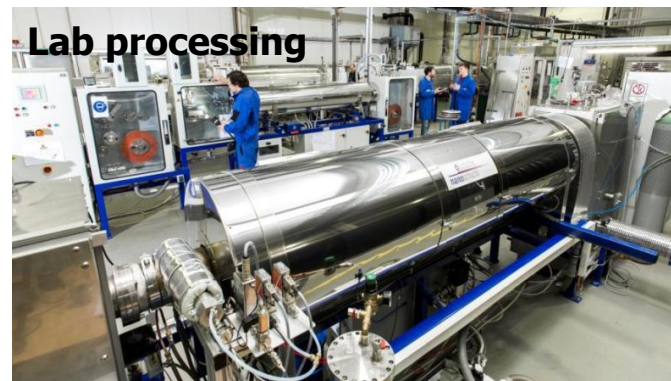
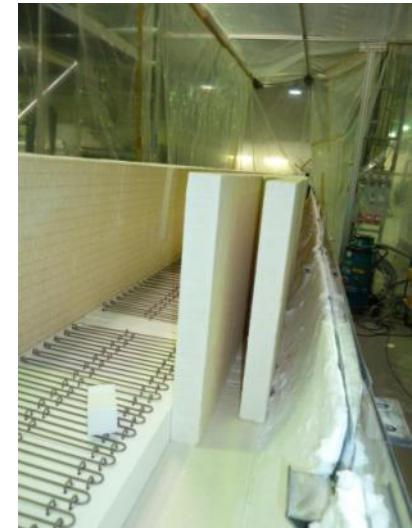
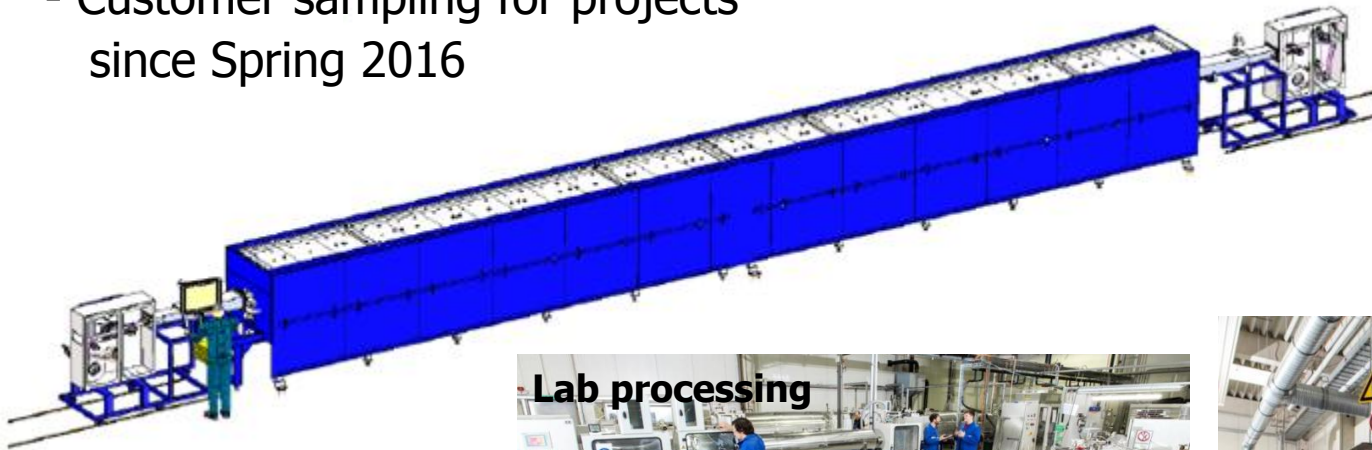


ink-jet printer

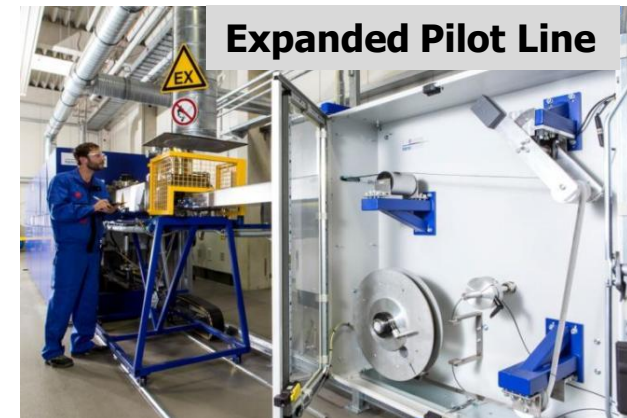


## D-Nano Expanded Pilot Line (EPL)

- Production capacity: >200km/yr (HTS conductor)
- Commissioned in 2016, fully operational in 2017
- In-house design/ construction of key technology
- Customer sampling for projects since Spring 2016



Lab processing

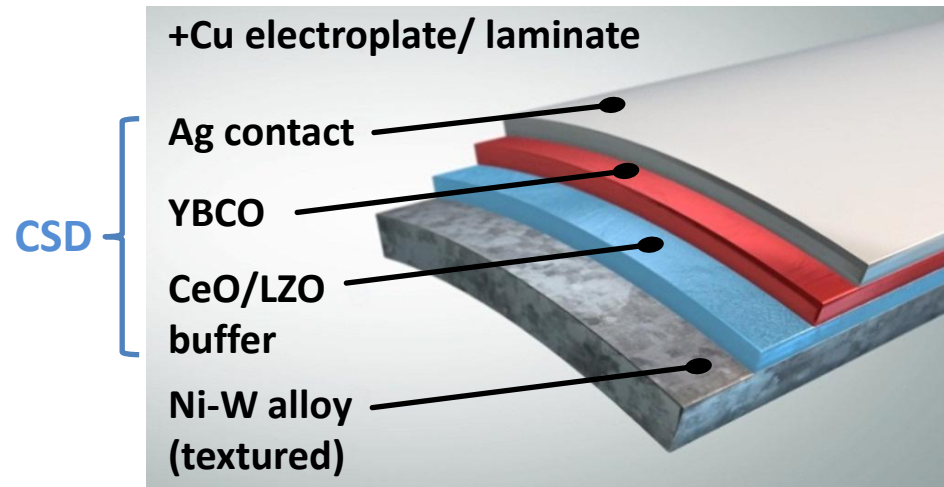


Expanded Pilot Line

## D-nano CSD conductor

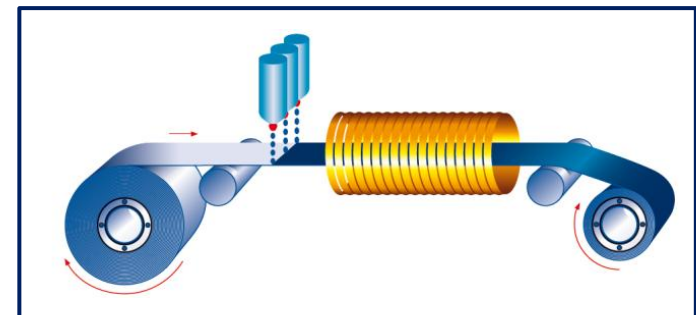
### • Architecture

- biaxially textured substrate Ni-W5/Ni-W9
- LZO+CeO buffers: CSD (300 nm)
- YBCO: TFA-CSD
- Ag contact: CSD (1000 nm)
- coating width: 10 mm -> 40 -> 100 mm
- protection: electro-plated Cu lamination



### • YBCO process/ properties

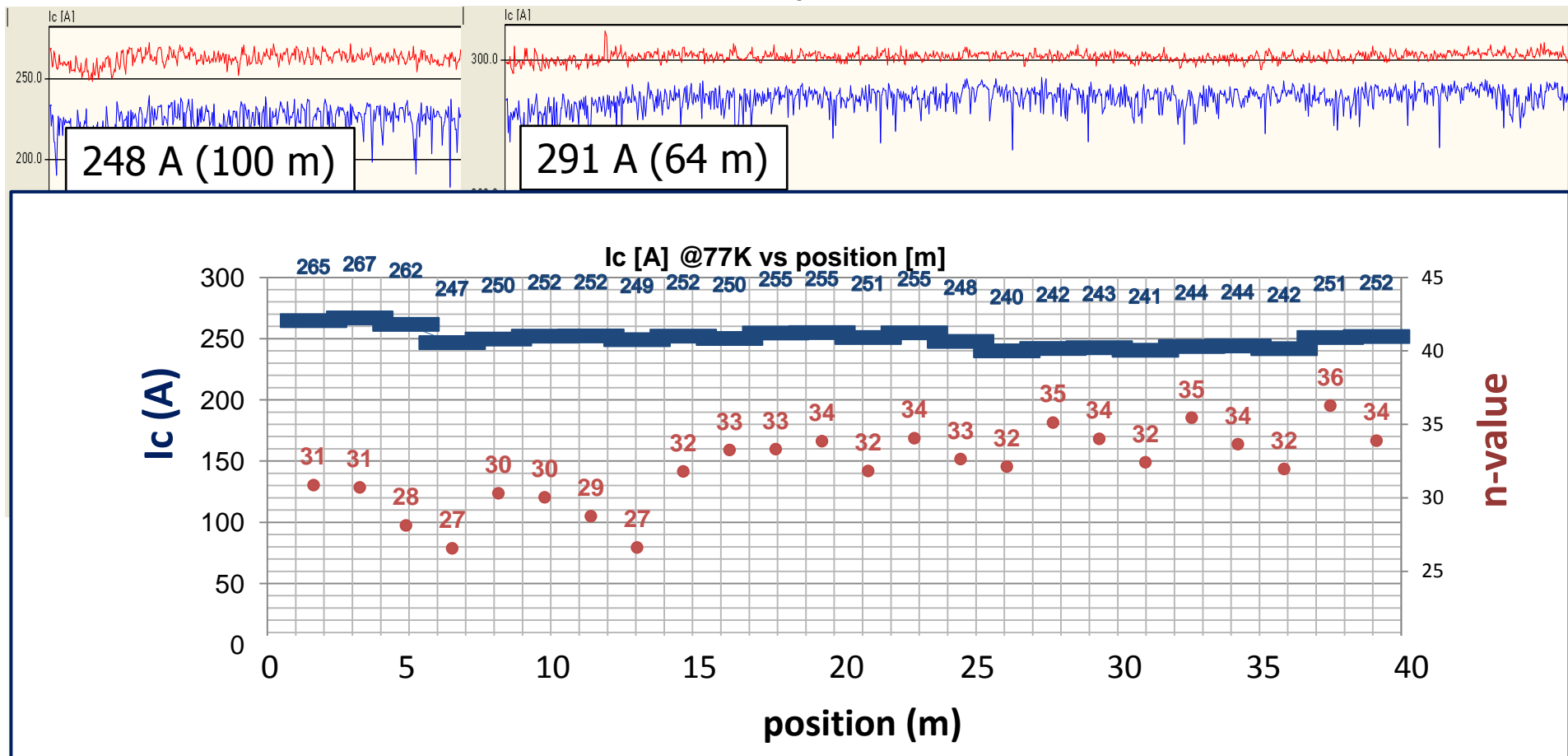
- slot-die coating, in-line pyrolysis (2-3x 500 nm)
- sub-atmospheric crystallization furnace (full-thickness)
- c-axis epitaxial laminar growth (GB meandering)
- $J_c = 1.8-2.5 \text{ MA/cm}^2$  (77 K, 0 T)
- $T_c = 88-91 \text{ K}$  (over-doped)
- pinning: growth-induced defects





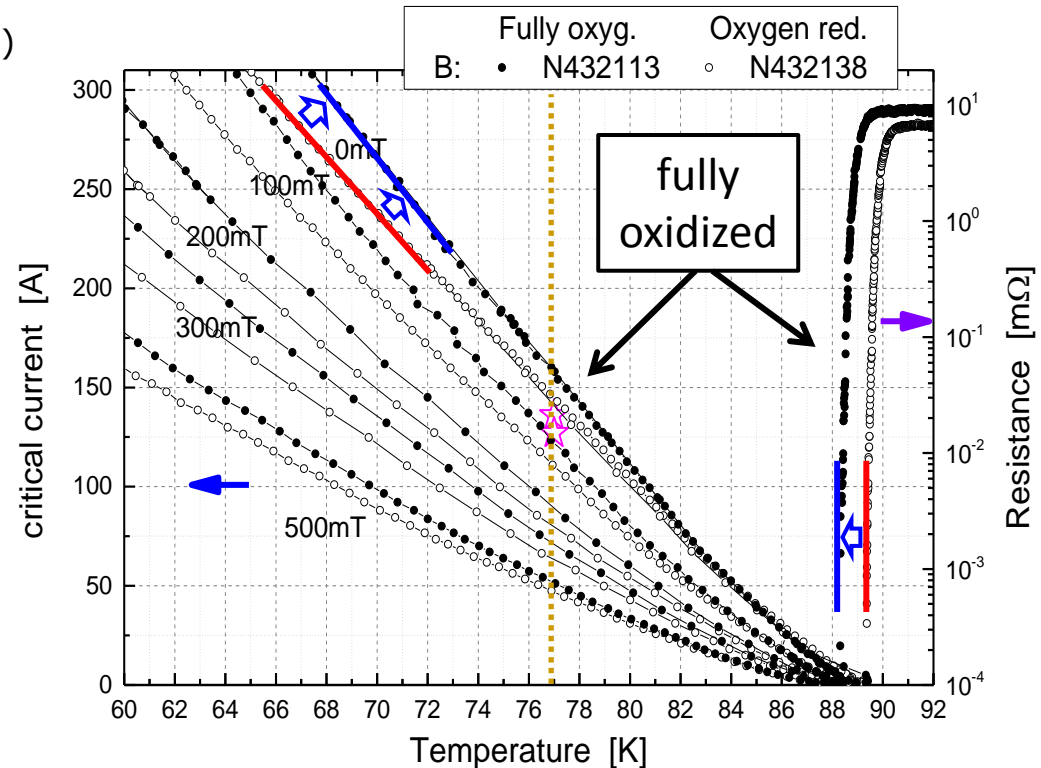
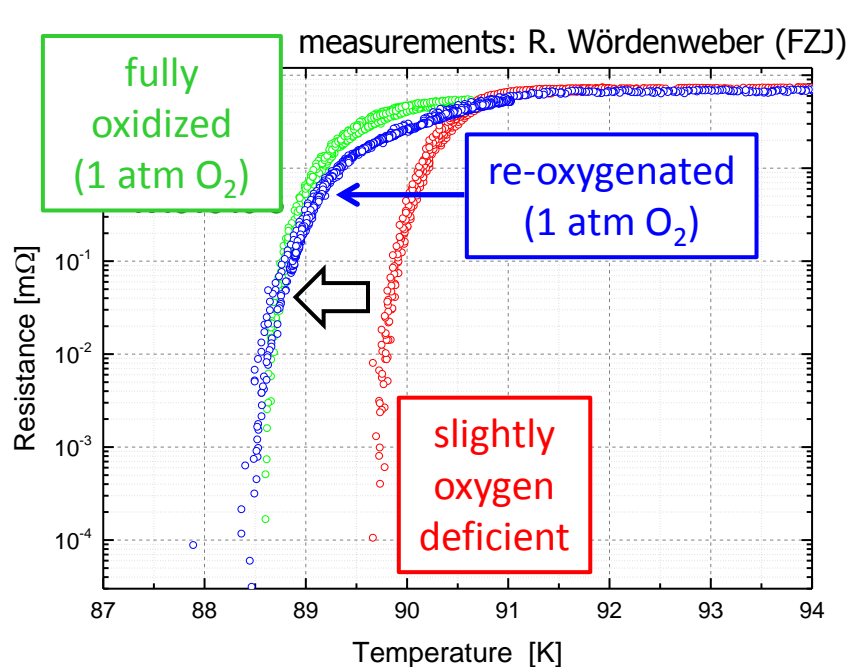
EPL produces 50-100 m tapes with  $I_c \cong 250-300$  A/cm

- TapeStar calibrated against transport  $I_c$  (homogenous tapes)



# Hole-overdoped YBCO: strong low-T and in-field performance

- overdoping:  $T_c$  decreases (slightly) after full oxygenation



*Phys. Rev. B* **45** (1991) 7555

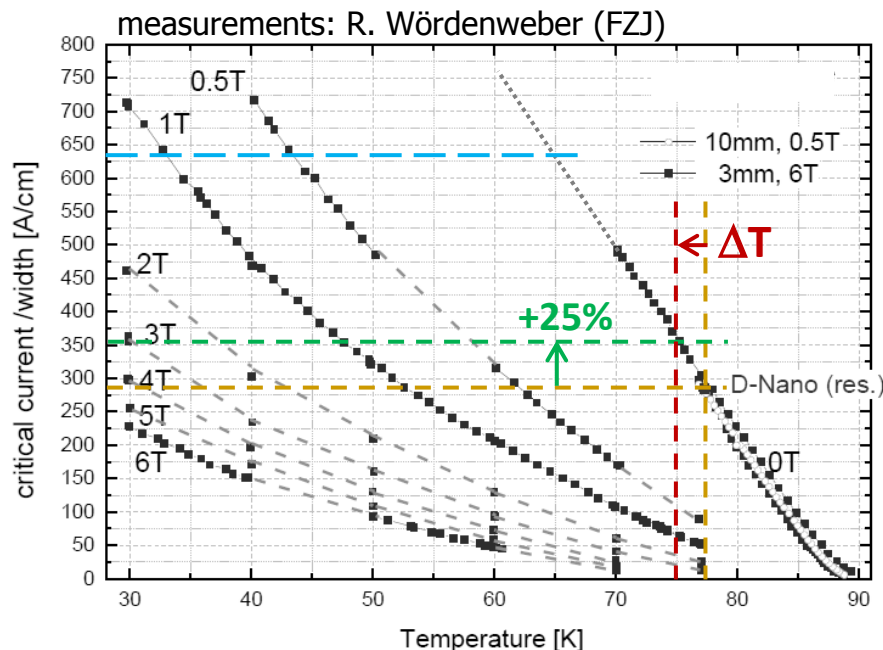
*Physica C* **416** (2004) 1

*Appl. Phys. Lett.* **104** (2014) 242601-1



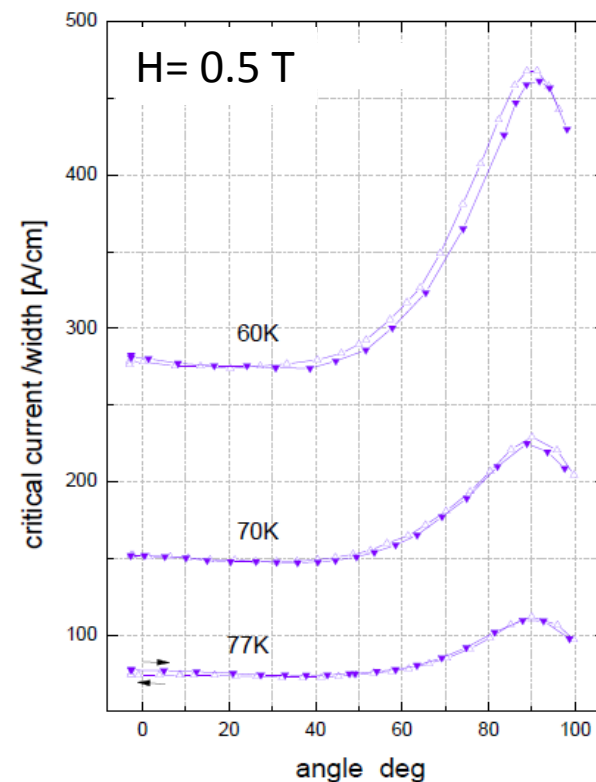
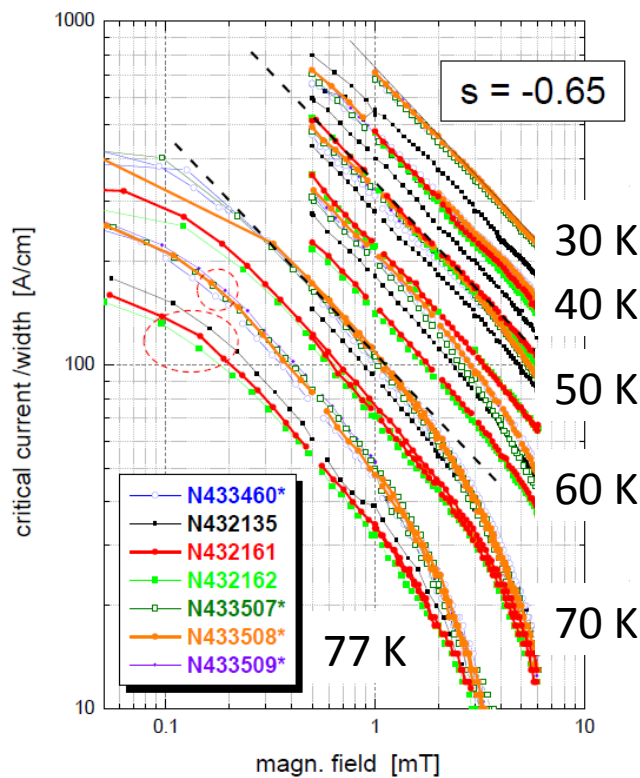
## $I_c$ depends strongly on operating temperature in LN2 regime

- $I_c$  increase with cooling below 77.3 K:  $\Delta I_c = +25\% \rightarrow |\Delta T| < 3\text{ K}$   
- similar after Cu-plating, Ni-W5at%, Ni-W9at% substrates
- Lift factor  $I_c(65\text{K}, 0\text{T})/I_c(77\text{K}, 0\text{T}) = 2.5$
- Lift factor  $I_c(30\text{K}, 1\text{T})/I_c(77\text{K}, 0\text{T}) = 2.5\text{-}2.9$



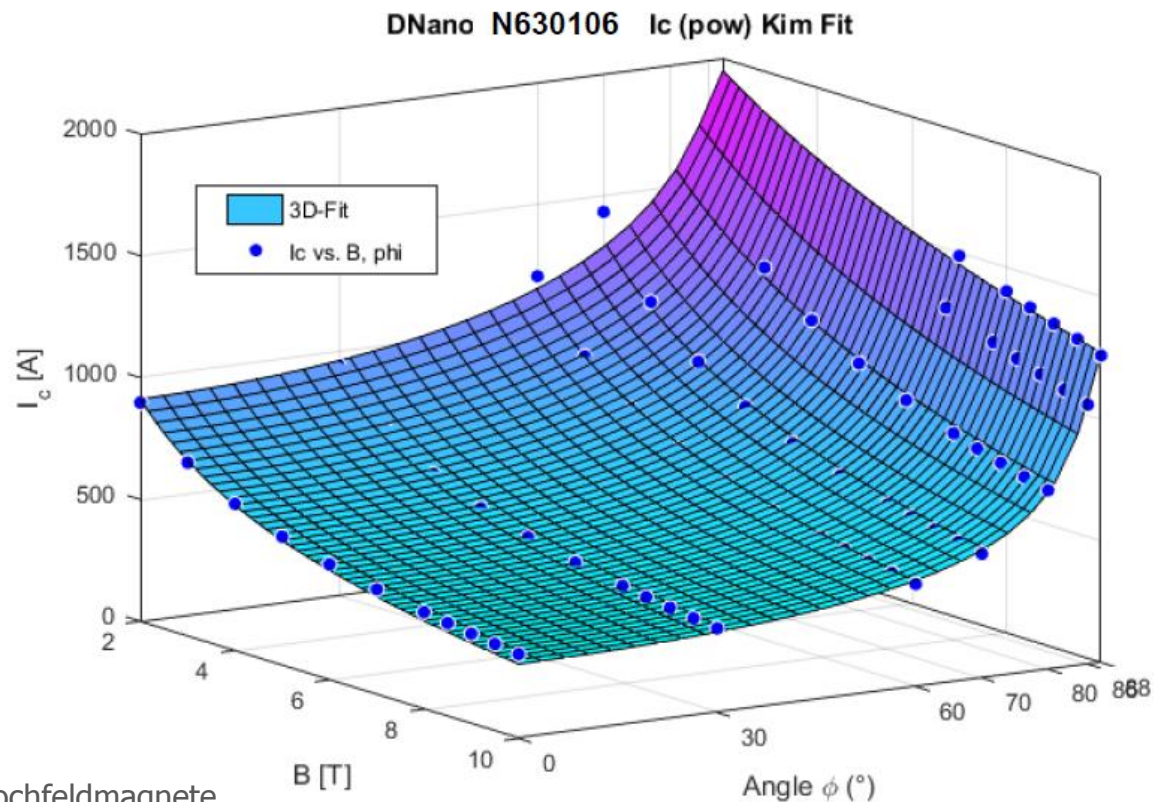
## H-field strength and orientation dependence of $I_c$ (typical)

- log-log  $I_c(H)$  coefficient  $|\alpha| = 0.65$
- semi-isotropic at 77 K -> stronger angular dependence at reduced T



## D-nano conductor exhibits strong behavior at 4.2 K

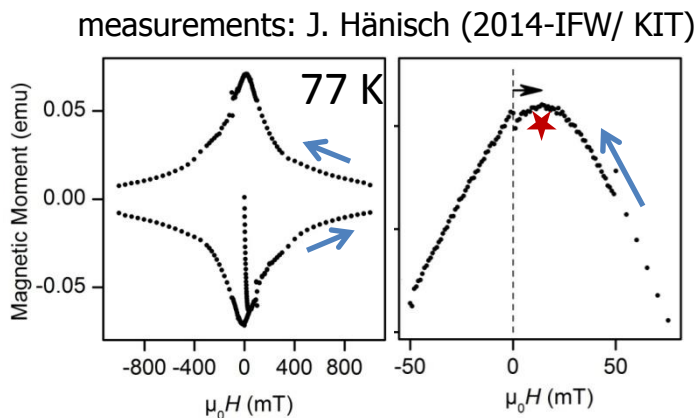
- High-current transport measurements at KIT
- $I_c(77\text{K}, 0\text{T}) = 247\text{ A}$  leads to  $I_c(4.2\text{K}, 10\text{T}) = \mathbf{350\text{ A}}$  (H||c) and  $\mathbf{900\text{ A}}$  (H||ab)





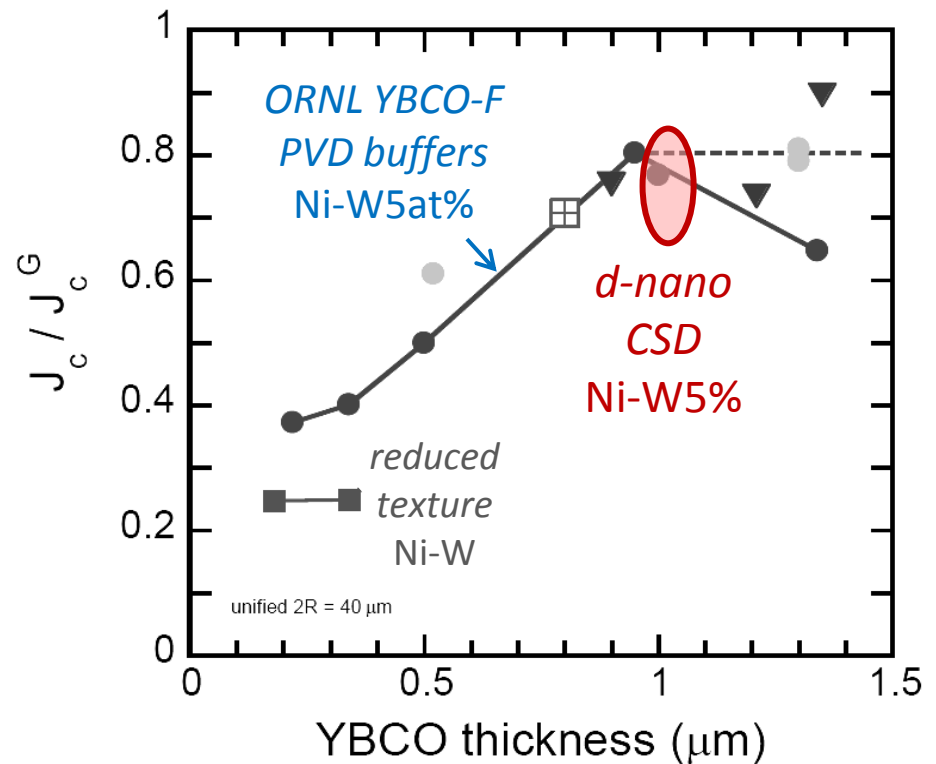
## CSD template enables efficient current transport

- 75-80% of maximum (intra-grain)  $J_c^G$  reached (1000 nm YBCO)
  - good metal/ buffer layer texture, grain boundary meandering



Intra-grain  $J_c^G$  derived from magnetic granularity effect (SQUID)

- $J_c^G = 2.3 \text{ MA/cm}^2$
- $J_c = 1.8 \text{ MA/cm}^2$



*Supercond. Sci. Technol.* **24** (2011) 062001

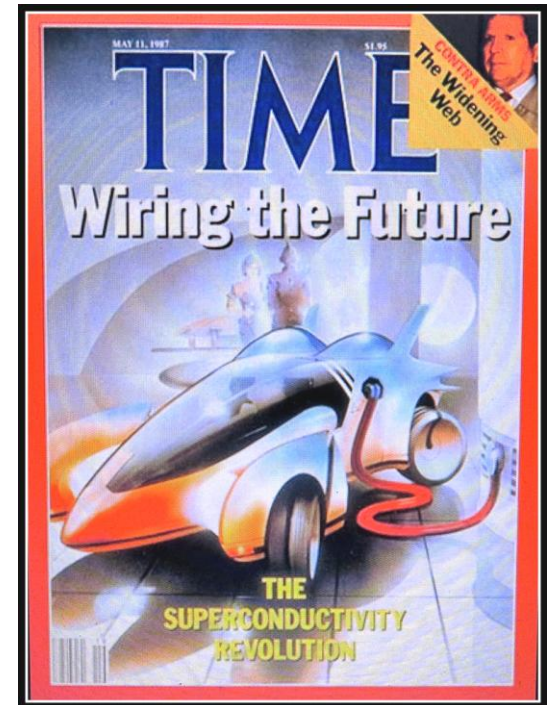
*J. Mater. Res.* **20** (2005) 2012

*Phys. Rev. B* **75** (2007) 054517

## Summary

- D-Nano developed all-CSD technology for YBCO wires
  - textured Ni-W substrate
  - CSD: LZO+CeO buffer layers, YBCO, Ag
- Extended Pilot Line: commissioned in 2016; fully operational in 2017
  - planned capacity: >200km/yr HTS conductor wire
  - presently: 1 cm tape width
  - scaling to 4 (10) cm-w in progress
- 50-100 m YBCO tapes with  $I_c \geq 250$  A/cm-w (77 K)
  - HTS conductor with electro-plated Cu (lamination)
  - back-to-back lamination doubles  $I_c$  (2x250 = 500 A)
- Sample tapes supplied to customers/ projects

Thank you for your attention!



May 11, 1987